OCT 2 9 2004 LIST

## (Filed on January 15, 2004)

Docket No.

GK-ZEI-3214 / 500343.20225

Applicant(s):

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ROSENKRANZ and Joern GREIF-WUESTENBECKER

Application No.

10/626,130

Group:

2872

Filed:

July 24, 2003

Examiner:

Fayez ASSAF

## **U.S. PATENT DOCUMENTS**

Exam. Init		Document Number	Date	Name	Class	Sub- Class	Filing Date Appropriate
TH	Al	6,522,717	2/18/03	Katsuhiko Murakami, et al.	378-	43-	
FA	AJ	5,848,119	12/8/98	Akira Miyake, et al.	378	34	
PA	AK	5,719,915	2/17/98	Masaki Koike, et al.	378	84	
es	AL	6,118,577	9/12/00	William C. Sweatt, et al.	-359	351	
	AM						
	AN						
	AO						

## FOREIGN PATENT DOCUMENTS

	Document				Sub-	Translation	
1	Number	Date	Country	CLASS	Class	YES	NO
AP							
AQ							
AR							
AS	•						
AT							
AU							

OTHER PRIOR ART (Including Author, Title, Date, Pertinent Pages, Etc.)

FA	AV	Article entitled: "High Energy X-Ray Phase Contrast Microscopy Using A Circular Bragg-Fresnel Lens" Optics Communications, North-Holland Publishing Co. Amsterdam, NL, Bd. 135, Nr. 4, 15 February 1997				
	AW					
·	AX					
	AY					
	AZ					

Examiner:	FAYEZ	ASSAF	 ate: \ /	<u>'5</u>	05

<sup>\*</sup>EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.